

MAPAN-Journal of Metrology Society of India

CALL FOR PAPERS

The *MAPAN-Journal of Metrology Society of India*, a leading SCI indexed quarterly publication, exclusively devoted to Metrology (Scientific, Industrial or Legal), is being published by Metrology Society of India in collaboration with Springer Nature India Pvt. Ltd.; National Physical Laboratory (NPLI) and Council of Scientific and Industrial Research (CSIR), New Delhi, India. In the past, several theme based special issues have been published in the journal on various aspects of metrology by eminent metrologists as **Guest Editors**. In continuation of such efforts, the journal has decided to publish another special issue on the following topic:

Special Issue Topic: Uncertainty Evaluation by Monte Carlo Method

Scheduled for Publication: March 2019

Guest Editors

Mr. Prem Rachakonda

Mechanical Engineer
Dimensional Metrology Group
National Institute of Standards & Technology (NIST)
100 Bureau Dr, MS 8211
Gaithersburg, MD 20899, USA
E-mail: prem.rachakonda@nist.gov

Mr. Vishal Ramnath

Department of Mechanical and Industrial Engineering,
University of South Africa
Private Bag X6, Florida 1710, Gauteng Province
Republic of South Africa
E-mail: ramnav@unisa.ac.za



Dr. V. S. Pandey

Assistant Professor, Physics
Department of Applied Sciences
National Institute of Technology, Delhi - 110 040, India
Email: vspandey@nitdelhi.ac.in



The journal invites the submission of research communications or technical articles on topics of current interest. Original work, tutorials and survey papers, which contribute to new knowledge or understanding of any metrology principle, method or technique, are welcome. Papers are considered for publication on the clear understanding that they have not been published previously or submitted to another journal for publication.

This journal is committed to upholding the integrity of the scientific record. As a member of the Committee on Publication Ethics (COPE) the journal will follow the COPE guidelines on how to deal with potential acts of misconduct.

Authors should refrain from misrepresenting research results which could damage the trust in the journal, the professionalism of scientific authorship, and ultimately the entire scientific endeavor. To maintain integrity of the research and its presentation, author should make sure that the manuscript has not been submitted to more than one journal for simultaneous consideration.

Papers should be clearly written in English and sent in duplicate to the Guest Editors, directly or Managing Editors (Dr. S. K. Jaiswal, skjaiswal@nplindia.org or Dr. Naveen Garg, ngarg@nplindia.org) of the journal. Paper can be directly on the journal submission portal: <http://www.editorialmanager.com/jmsi/>, under the special issue category.

The journal may use software to screen for plagiarism. The papers accepted for publication are subjected to peer review process by 2 reviewers/experts of the subject or by the Guest Editors. Generally, no more than three papers from a particular institution permitted, unless it is justified by the Guest Editors and authorized in advance by journal editorial committee.

Guest Editors' Role: Preparing call for papers to send/public announcement to authors with a copy sent to Managing Editors (Dr. S. K. Jaiswal, skjaiswal@nplindia.org or Dr. Naveen Garg, ngarg@nplindia.org)/Editor-in-Chief (Dr. Sanjay Yadav, syadav@nplindia.org). The announcement to this effect will also be made on MSI website: www.metrologyindia.org. The Guest Editors are also responsible for arranging the required reviews of the papers.

INSTRUCTIONS TO CONTRIBUTORS

Elements of the Manuscripts

- A cover sheet consists of a short title, name, affiliation and address of all authors.
- Manuscript must start from the next page with title on top of the page.
- An abstract of about 100-200 words should be provided on the title page. This should be readable without reference to the article and should indicate the scope of the contribution, including the main conclusions.
- An introduction, which may begin with what is new in the paper, not with statement that is well known to everyone.
- Appropriate section of the text.
- A conclusion.
- An acknowledgement (optional).
- A list of references in a relevant format described in the next section.
- A set of original figures and tables.
- A list of captions for all figures and title for all tables.

References

References must be prepared in proper format (examples of various types are given below) and numbered consecutively in the order in which they are cited in the text.

- **Books:** Authors name, title of the book, publisher, year, pp. first and last page no.
- **Periodicals:** Author(s) name, title of article, name of journal, vol. no.(year), pp. first and last page no.
- Example: [1] G. B. Gao and X. Gui, Reliability Physics as a new discipline, *Microelectron. Reliab.*, **28(1988) 713–720**.
- **Conference records:** Author(s) name, title of article, name of conference, place where held(year), pp. first and last page no.
- **Unpublished conference presentations:** Author(s) name, title of article, name of conference, place where held, year.
- **Technical reports:** Author(s) name, title of article, report no., published by, year.

Copyright

Authors have to fill the transfer of copyright form at the time of submission of paper for publication.

Right of Publication

The Publication & Information Committee of Metrology Society of India reserves the right of publication. The committee is not responsible for the views expressed by the authors.



<http://www.springer.com/journal/12647>

MAPAN

Journal of Metrology Society of India

Editor-in-Chief: Yadav, S.

ISSN: 0970-3950 (print version)

ISSN: 0974-9853 (electronic version)

Journal no. 12647



<http://www.springer.com/journal/12647>

MAPAN

Journal of Metrology Society of India

Editor-in-Chief: Yadav, S.

ISSN: 0970-3950 (print version)

ISSN: 0974-9853 (electronic version)

Journal no. 12647